

# PIC24F16KA102 FAMILY

## PIC24F16KA102 Family Silicon Errata and Data Sheet Clarification

The PIC24F16KA102 family devices that you have received conform functionally to the current Device Data Sheet (DS39927**B**), except for the anomalies described in this document.

The silicon issues discussed in the following pages are for silicon revisions with the Device and Revision IDs listed in Table 1. The silicon issues are summarized in Table 2.

The errata described in this document will be addressed in future revisions of the PIC24F16KA102 family silicon.

Note: This document summarizes all silicon errata issues from all revisions of silicon, previous as well as current. Only the issues indicated in the last column of Table 2 apply to the current silicon revision (**B0**).

Data Sheet clarifications and corrections start on page 7, following the discussion of silicon issues.

The silicon revision level can be identified using the current version of  $MPLAB^{(\!R\!)}$  IDE and Microchip's programmers, debuggers and emulation tools, which are available at the Microchip corporate web site (www.microchip.com).

For example, to identify the silicon revision level using MPLAB IDE in conjunction with MPLAB ICD 2 or PICkit<sup>™</sup> 3:

- 1. Using the appropriate interface, connect the device to the MPLAB ICD 2 programmer/debugger or PICkit<sup>™</sup> 3.
- 2. From the main menu in MPLAB IDE, select <u>Configure>Select Device</u> and then select the target part number in the dialog box.
- 3. Select the MPLAB hardware tool (<u>Debugger>Select Tool</u>).
- Perform a "Connect" operation to the device (<u>Debugger>Connect</u>). Depending on the development tool used, the part number and Device Revision ID value appear in the Output window.

**Note:** If you are unable to extract the silicon revision level, please contact your local Microchip sales office for assistance.

The DEVREV values for the various PIC24F16KA102 family silicon revisions are shown in Table 1.

TABLE 1:	SILICON DEVREV VALUES
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Part Number		Revision ID for Silicon Revision <sup>(2)</sup>					
	Device ID.	A5	A6	A7	B0		
PIC24F08KA101	0B08h			07h	08h		
PIC24F08KA102	0B0Ah	05h	06h				
PIC24F16KA101	0B01h	0511					
PIC24F16KA102	0B03h						

**Note 1:** The Device IDs (DEVID and DEVREV) are located at the last two implemented addresses in program memory. They are shown in hexadecimal in the format, "DEVID DEVREV".

2: Refer to the "PIC24FXXKAXXX Flash Programming Specification" (DS39919) for detailed information on Device and Revision IDs for your specific device.

Mashala	Fratime	Item	1 0	Afi	ected R	evision	s <sup>(1)</sup>
wodule	Feature	Number	Issue Summary	A5	A6	A7	B0
CTMU	_	1.	Module operates in Sleep mode.	Х	Х	Х	
Resets	BOR	2.	Inadvertent Reset when disabling/enabling BOR.	Х	Х	Х	Х
Core	ICSP™	3.	Unable to use PGC/PGD pair under certain conditions.	Х			
Core	Deep Sleep	4.	Failure to avoid Deep Sleep entry.	Х	Х	Х	
Memory	Code Protection	5.	No direct jump to Boot Sector from Reset Vector.	Х			
Comparator	_	6.	Change in maximum VIOFF.	Х	Х	Х	Х
SPI	Enhanced Buffer mode	7.	Errors when polling SPITBF flag.	Х	Х	Х	
I/O Ports	PORTA and PORTB	8.	Under certain conditions, functionality for RB0 and RA0 pins do not work correctly.	Х	Х	Х	
I/O Ports	PORTA and PORTB	9.	Under certain conditions, functionality for RB2 does not work correctly.	Х	Х	Х	
Core	Low-Voltage BOR	10.	LPBOR configuration results in ambiguous Resets.	Х	Х	Х	
Comparator	I/O Pins	11.	Enabling comparator outputs disables some digital I/O ports.	Х	Х	Х	Х
Comparator	-	12.	Output polarity inversion also inverts edge-detect sensing.	Х	Х	Х	Х
Core	Doze mode	13.	Instruction execution glitches following DOZE bit changes.	Х	Х	Х	

## TABLE 2: SILICON ISSUE SUMMARY

Note 1: Only those issues indicated in the last column apply to the current silicon revision.

## Silicon Errata Issues

Note: This document summarizes all silicon errata issues from all revisions of silicon, previous as well as current. Only the issues indicated by the shaded column in the following tables apply to the current silicon revision (**B0**).

## 1. Module: CTMU

The CTMU and its current source may continue to operate in Sleep mode. This results in current consumption in excess of the specifications for Sleep.

## Work around

Clear the CTMU Enable bit (CTMUCON<15>) prior to entering Sleep mode.

### Affected Silicon Revisions

A5	A6	A7	B0		
Х	Х	Х			

## 2. Module: Resets (BOR)

A device Reset may occur if the BOR is disabled and immediately re-enabled in software (RCON<14> is cleared and then immediately set).

## Work around

It is recommended that several NOP instructions be added to a BOR disable/enable sequence. Alternatively, place several instructions or a short routine between the instructions to disable and enable the BOR.

#### Affected Silicon Revisions

A5	A6	A7	B0		
Х	Х	Х	Х		

## 3. Module: Core (ICSP<sup>™</sup>)

Under certain circumstances, a PGC/PGD pin pair may not function to enter ICSP Programming mode. This has been observed only when both the following conditions are met:

- a) Pin, RA5, is configured as MCLR (FPOR<5> = 1), and
- b) The pins of the PGEC/PGED pair were configured as digital outputs (corresponding TRIS bit cleared) in software.

In these circumstances, the pins do not switch to a high-impedance state upon entry into Programming mode, but remain configured as outputs.

## Work around

Choose a PGC/PGD pair with pins that are always configured as inputs (TRIS bits are set).

### Affected Silicon Revisions

A5	A6	A7	B0		
Х					

## 4. Module: Core (Deep Sleep)

Deep Sleep wake-up sources may be ignored if they occur just prior to entry into Deep Sleep mode. As a result, the device may enter Deep Sleep mode when it should not.

## Work around

If possible, configure external Deep Sleep wake-up sources to repeat themselves once. If the device does enter Deep Sleep, the second occurrence of the wake-up source will wake the device.

Alternatively, synchronize the entry into Deep Sleep with external wake-up sources, where possible.

## Affected Silicon Revisions

A5	A6	A7	B0		
Х	Х	Х			

## 5. Module: Memory (Code Protection)

When any boot segment is enabled in program memory (FBS<3:1>  $\neq$  111), it is not possible to jump directly from the Reset vector to any address in the boot segment.

## Work around

Point the Reset vector to an address in the general segment. From there, it is possible to jump into the boot segment.

## Affected Silicon Revisions

A5	A6	A7	B0		
Х					

## 6. Module: Comparator

The maximum value for the input offset voltage (specification D300, VIOFF), shown in Table 29-13 of the Device Data Sheet, has changed for this silicon revision. The new value is shown in Table 3 (changes in **bold**).

### Work around

None.

### Affected Silicon Revisions

A5	A6	A7	B0		
Х	Х	Х	Х		

## 7. Module: SPI (Enhanced Buffer Mode)

In Enhanced Buffer mode (SPI1CON2<0> = 1), polling the SPI Transmit Buffer Full bit, SPITBF (SPI1STAT<1>), may produce erroneous results. This occurs only under two circumstances:

- a) In Master mode, when the SPI divide clock is 4 or greater.
- b) In Slave mode, when the SPI sample clock is slower than 1/4 of the CPU instruction time (TCY).

For Master mode, this includes all combinations of the primary prescale bits (SPI11CON1<1:0>) and secondary prescale bits (SPI1CON1<4:2>) that, when combined, create an SPI sample clock divisor with a value of four or greater.

## Work around

Instead of polling the SPITBF bit to test for an empty buffer (SPI1STAT<1> = 0), implement a SPI receive interrupt handler in software and add to the SPI transmit buffer in this routine.

Alternatively, poll the SPI Receive Full bit, SPIRBF (SPI1STAT<0>), or the Shift Register Empty bit, SRMPT (SPI1STAT<7>), to determine when to service the SPI transmit and transmit buffers.

## Affected Silicon Revisions

A5	A6	A7	B0		
Х	Х	Х			

## TABLE 3: COMPARATOR DC SPECIFICATIONS (PARTIAL)

Param No.	Symbol	Characteristics	Min	Тур	Max	Units	Comments
	VIOFF	Input Offset Voltage	_	20	60	mV	

## 8. Module: I/O Ports (PORTA and PORTB)

The functions associated with port pins, RB0 and RA0, may be interconnected in unexpected ways.

PORTB pin, RB0, may not operate correctly as an input if the SPI module is enabled (SPI1CON<15> = 1). Additionally, the pull-up, pull-down and the Change Notification (CN4) functionality are disabled. RB0 does operate correctly with the SPI enabled if it is configured as an output.

PORTA pin, RA0, may not operate correctly as an input when the open-drain output is enabled for RB0 (ODCB<0>). RA0 will operate correctly as an output.

However, when the analog input on RB0 (AN2) is enabled (AD1PCFG<2> = 0) and the SPI module is enabled, RB0 will be driven as a digital output, not as a analog input.

## Work around

To enable RB0 as a digital input, enable the open-drain output for RB0 (ODCB<0>) and set the latch bit (LATB<0> = 1). The Change Notification (CN4), pull-up and pull-down for this pin will function correctly as well.

This work around may cause RA0 to function incorrectly. There is no known work around for RA0 as an input and RB0 with the open-drain output enabled.

To enable RB0 as an analog input when SPI is enabled:

- 1. Enable the open-drain output for RB0 (ODCB<0>).
- 2. Set the latch bit (LATB<0> = 1).
- 3. Clear TRISB<0>.
- 4. Clear AD1PCFG<2>.

## Affected Silicon Revisions

Α	5	A6	A7	B0		
>	(	Х	Х			

## 9. Module: I/O Ports (PORTA and PORTB)

Note:	This	issue	occurs	in	PIC24FXXKA101
	(20-р	oin) dev	vices only	y.	

On 20-pin devices of the PIC24F16KA102 family, the functions associated with port pins, RB2 and RA2, may be interconnected in unexpected ways.

PORTB pin, RB2, may not operate correctly as a digital I/O if the analog input on PORTA pin, RA2 (AN4), is enabled (AD1PCFG<4> = 0). Both the digital port, and the U1RX functionality multiplexed to RB2, are disabled.

Although this issue is similar in form to silicon issue 8, it appears to be independent in its root cause.

## Work around

None.

### Affected Silicon Revisions

A5	A6	A7	B0		
Х	Х	Х			

## 10. Module: Core (Low-Power BOR)

When the Low-Power BOR is enabled (FPOR<6:5> = 00), BOR events may result in a device Reset in which both the BOR and POR bits are set.

This differs from the expected behavior of simply re-arming the POR circuit to ensure that a POR occurs when VDD drops below the POR threshold.

## Work around

None.

## Affected Silicon Revisions

A5	A6	A7	B0		
Х	Х	Х			

## 11. Module: Comparator (I/O Pins)

Certain I/O pins may not function correctly as digital inputs or outputs after specific comparator outputs have been enabled with the COE bit (CMxCON<14> = 1). These are:

- RB14 (with Comparator 1)
- RA6 (with Comparator 2)

This condition may continue even after the comparator in question has been disabled, using the corresponding CON bit (CMxCON<15> = 0).

## Work around

In addition to clearing the CON bit, also clear the COE bit.

#### Affected Silicon Revisions

A5	A6	A7	B0		
Х	Х	Х	Х		

## 12. Module: Comparator

When a comparator is programmed to trigger on certain edge-detect events (CMxCON<7:6> = 10 or 01), setting the CPOL bit (CMxCON<13> = 1) may cause the comparator to flag the opposite edge-detect event (e.g., a high-to-low edge instead of the programmed low-to-high).

### Work around

Leave CPOL = 0. In addition, use the opposite setting of CMxCON<7:6> to achieve the correct response (e.g., use '10' for '01').

## Affected Silicon Revisions

A5	A6	A7	B0		
Х	Х	Х	Х		

## 13. Module: Core (Doze Mode)

Operations that immediately follow any manipulations of the DOZE<2:0> or DOZEN bits (CLDIV<14:11>) may not execute properly. In particular, for instructions that operate on an SFR, data may not be read properly. Also, bits automatically cleared in hardware may not be cleared if the operation occurs during this interval.

## Work around

Always insert a  $\mathbb{NOP}$  instruction before and after either of the following:

- Enabling or disabling Doze mode by setting or clearing the DOZEN bit
- Before or after changing the DOZE<2:0> bits

### Affected Silicon Revisions

A5	A6	A7	B0		
Х	Х	Х			

## **Data Sheet Clarifications**

The following typographic corrections and clarifications are to be noted for the latest version of the Device Data Sheet (DS39927**B**):

Note:	Corrections are shown in <b>bold</b> . Where
	possible, the original bold text formatting
	has been removed for clarity.

## 1. Module: Memory

In Table 4-4, the CN9IE, CN9PUE and CN9PDE bits (CNEN1<9>, CNPU1<9> and CNPD1<9>, respectively) are not implemented on 20-pin devices. These bits are to be marked with the existing footnote 1 ("These bits are not implemented in 20-pin devices").

## 2. Module: Electrical Specifications (AC Specifications)

In Table 29-25, the maximum Differential Nonlinearity specification for the A/D module (parameter AD22b) has changed. The new value is shown below (changes in bold).

## TABLE 29-25: ADC MODULE SPECIFICATIONS

AC CHARACTERISTICS			Standard C Operating	$\label{eq:standard} \begin{array}{l} Standard \ Operating \ Conditions: \ 1.8V \ to \ 3.6V \ (unless \ otherwise \ stated) \\ Operating \ temperature \ -40^{\circ}C \leq TA \leq +85^{\circ}C \ for \ Industrial \end{array}$					
Param No.	Symbol	Characteristic	Min.	Тур	Max.	Units	Conditions		
-	ADC Accuracy								
AD22b	DNL	Differential Nonlinearity	—	±1	-1 +1.5	LSb	VINL = AVSS = VREFL = 0V, AVDD = VREFH = 3V		

Note 1: The ADC conversion result never decreases with an increase in the input voltage and has no missing codes.

2: Measurements taken with external VREF+ and VREF- used as the ADC voltage reference.

## 3. Module: Electrical Specifications (DC Specifications)

In Table 29-6, the values for parameters, DC20d and DC20e (IDD for Deep Sleep), have changed. The corrected values are shown below (changes in bold).

## TABLE 29-6: DC CHARACTERISTICS: OPERATING CURRENT (IDD)

DC CHARACTER	RISTICS		$\begin{array}{llllllllllllllllllllllllllllllllllll$				
Parameter No.	Typical <sup>(1)</sup>	Max	Units Conditions				
IDD Current							
DC20		330		-40°C			
DS20a	105	330	μΑ	+25°C	- 1.8V		
DC20b	195	330		+60°C			
DC20c		330		+85°C		0.5 MIPS,	
DC20d		590		-40°C		Fosc = 1 MHz	
DC20e	265	590	A	+25°C			
DC20f	305	645	μΑ	+60°C	3.3V		
DC20g		720		+85°C			

Note 1: Data in "Typical" column is at 3.3V, 25°C unless otherwise stated. Parameters are for design guidance only and are not tested.

- 2: Operating Parameters:
  - · EC mode with clock input driven with a square wave rail-to-rail
  - I/O configured as outputs driven low
  - MCLR VDD
  - WDT FSCM disabled
  - SRAM, program and data memory active
  - All PMD bits set except for modules being measured

# 4. Module: Electrical Specifications (DC Specifications)

In Table 29-8, the typical values for the Watchdog Timer Current at 1.8V and all temperatures (parameters D61 through D61C) are changed to  $0.55 \ \mu$ A.

# 5. Module: Electrical Specifications (DC Specifications)

In Table 29-8, footnote 2 includes the text: "All I/Os are configured as inputs and pulled high....". This is changed to read as, "All I/Os are configured as outputs and set low....".

## 6. Module: A/D

In Register 22-3, the values shown for AD1CON3<5:0> (ADCS<5:0>) are incorrect. The corrected values are shown below (changes in bold).

## REGISTER 22-3: AD1CON3: A/D CONTROL REGISTER 3

R/W-0	U-0	U-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0
ADRC	—	—	SAMC4	SAMC3	SAMC2	SAMC1	SAMC0
bit 15							bit 8

U-0	U-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0
—	—	ADCS5	ADCS4	ADCS3	ADCS2	ADCS1	ADCS0
bit 7							bit 0

Legend:			
R = Readable bit	W = Writable bit	U = Unimplemented bit, read	l as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 5-0 ADCS<5:0>: A/D Conversion Clock Select bits

111111 = 64 • TCY 111110 = 63 • TCY • • 000001 = 2 • TCY 000000 = TCY

## 7. Module: Comparators

The descriptions given for the CMIDL bit (CMSTAT<15>) are incorrect. The correct descriptions are shown below (changes in bold).

## REGISTER 23-2: CMSTAT: COMPARATOR MODULE STATUS REGISTER

R/W-0	U-0	U-0	U-0	U-0	U-0	R-0, HSC	R-0, HSC
CMIDL	—	_	—	—		C2EVT	C1EVT
bit 15							bit 8
U-0	U-0	U-0	U-0	U-0	U-0	R-0, HSC	R-0, HSC
—	_	—	—	—	—	C2OUT	C1OUT
bit 7							bit 0

Legend:	HSC = Hardware Settable/Clearable bit				
R = Readable bit W = Writable bit		U = Unimplemented bit, read as '0'			
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown		

### bit 15 CMIDL: Stop in Idle Mode bit

1 = Disable comparator interrupts when the device enters Idle mode; the module is still enabled

0 = Continue normal module operation in Idle mode

#### 8. Module: Pin Diagrams

In many places in the data sheet, the UART Baud Clock output functions, U1BCLK and U2BCLK, are shown as being multiplexed on the same pins as the UART Receive input functions (U1RX and U2RX). The Baud Clock is actually multiplexed with the UART Ready-to-Send output function (U1RTS and U2RTS) on completely different pins. This mapping is correctly described in the UART chapter, but incorrectly shown on pin diagrams and pin function listings.

The pin diagrams from the data sheet are replaced by the pin diagrams shown in Figure 1, Figure 2 and Figure 3. Changes are noted in bold. Footnotes present in the original diagrams have been omitted here for clarity.

In addition, Table 1-2 of the device data sheet is amended as shown. Footnotes in the original table have been omitted for clarity. Changes are indicated in bold.

## FIGURE 1: PIN DIAGRAMS







# PIC24F16KA102 FAMILY



## TABLE 1-2: PIC24F16KA102 FAMILY PINOUT DESCRIPTIONS (PARTIAL REPRESENTATION)

		Pin I	Number					
Function	20-Pin PDIP/SSOP/ SOIC	20-Pin QFN	28-Pin SPDIP/ SSOP/SOIC	28-Pin QFN	I/O	Input Buffer	Description	
AN0	2	19	2	27	I	ANA	A/D Analog Inputs	
AN1	3	20	3	28	I	ANA		
AN2	4	1	4	1	I	ANA		
AN3	5	2	5	2	I	ANA		
AN4	7	4	6	3	I	ANA		
AN5	8	5	7	4	I	ANA		
AN10	17	14	25	22	I	ANA		
AN11	16	13	24	21	I	ANA		
AN12	15	12	23	20	I	ANA		
U1BCLK	13	10	18	15	0	_	UART1 IrDA <sup>®</sup> Baud Clock	
U2BCLK	9	6	11	8	0	_	UART2 IrDA Baud Clock	

## 9. Module: A/D Converter (AD1CHS Register)

In Register 22-4, the bit fields, CHOSB<3:0> and CHOSA<3:0>, both assign the value '0110' to both AVDD and AVSS inputs. For both bit fields, '0111' corresponds to AVDD and '0110' corresponds to AVSS.

Also, the bit fields, CHOSB<3:0> and CHOSA<3:0>, both assign the value, '0010', to both AN2 and AN3 inputs. For both bit fields, '0011' corresponds to AN3 and '0110' corresponds to AN2.

In addition, the CH0SA bit field is only four bits wide, comprising AD1CHS<3:0>; CH0SA4 is not implemented. This deletion applies to all occurrences of CH0SA4, including the device memory map.

All changes to AD1CHS are shown in Register 22-4 below; changes are in bold.

## REGISTER 22-4: AD1CHS: A/D INPUT SELECT REGISTER (PARTIAL REPRESENTATION)

R/W-0	U-0	U-0	U-0	R/W-0	R/W-0	R/W-0	R/W-0
CH0NB	—	—	—	CH0SB3	CH0SB2	CH0SB1	CH0SB0
bit 15							bit 8

R/W-0	U-0	U-0	U-0	R/W-0	R/W-0	R/W-0	R/W-0
CH0NA	—	—	—	CH0SA3	CH0SA2	CH0SA1	CH0SA0
bit 7 bit 0							

Legend:			
R = Readable bit	W = Writable bit	U = Unimplemented bit, read	1 as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 11-8 CH0SB<3:0>: Channel 0 Positive Input Select for MUX B Multiplexer Setting bits 1111 = Channel 0 positive input is band gap reference (VBG)

	1000 <b>= Reserved</b>
	0111 = AVDD
	0110 <b>= AV</b> ss
	0100 = Channel 0 positive input is AN4
	0011 = Channel 0 positive input is AN3
	0010 = Channel 0 positive input is AN2
	···· · · · · · · · · · · · · · · · · ·
4-0	CH0SA<4:0>: Channel 0 Positive Input Select for Sample A bits
	1111 = Channel 0 positive input is band gap reference (VBG)
	·
	1000 = Reserved
	$0111 - \Delta V D$
	0110 = AVSS
	0110 - 7035
	0100 - Channel O positivo input is ANA
	0100 - Channel O positive input is AN2
	0011 = Channel 0 positive input is AN3
	0010 = Channel 0 positive input is AN2

bit

## 10. Module: A/D Converter

In Figure 22-2, the interconnect resistance, Ric, is shown as having a value of no more than 250W. The proper value for Ric is no more than 250 **ohms**.

## 11. Module: Special Features (Configuration Bits)

In the FDS Configuration register, the Configuration bits, DSLPBOR and DSWCKSEL (FDS<6,4>), have been renamed: DSBOREN and DSWDTOSC. This has been done to unify the naming conventions for all nanoWatt XLP devices. The changes apply to all occurrences throughout the device data sheet.

It is anticipated that the former names of these bits will be supported through the next release of all Microchip development tools.

## 12. Module: Power-Saving Features

The Deep Sleep Wake-up Source register, DSWSRC (Register 10-2), has been renamed DSWAKE. This has been done to unify the naming conventions for all nanoWatt XLP devices. This change applies to all occurrences throughout the device data sheet, including the device memory map.

It is anticipated that the register name, DSWSRC, will be supported through the next release of all Microchip development tools.

## 13. Module: Electrical Specifications (AC Specifications)

Parameter, AD08 (current specification for the external ADC voltage reference), has been added to the specifications for the A/D module. Table 29-25 is amended as shown (additions in **bold**).

## 14. Module: Electrical Specifications (DC Specifications)

In Table 29-9 ("DC Characteristics: I/O Pin Input Specifications"), the maximum value of Parameter D151, the input leakage current (IIL) on the VREF+ and VREF- pins has been changed to +1.00  $\mu$ A. The rest of the parameter is unchanged.

			_	1.0	_	mA	VREF+ = 3.3V; converting
AD08	IVREF+	External VREF+ Current	—	<u> </u>		μA	VREF+ = 3.3V; sampling
	Voltage						
AD07	VREF	Absolute Reference	AVss - 0.3	—	AVDD + 0.3	V	
AD06	VREFL	Reference Voltage Low	AVss	_	AVDD - 1.7	V	
AD05	Vrefh	Reference Voltage High	AVss + 1.7		AVdd	V	
Reference Inputs							
Param No.	Symbol	Characteristic Min. Typ Max. I		Units	Conditions		
AC CHA	ARACTERIS	TICS	$\begin{array}{llllllllllllllllllllllllllllllllllll$				

## TABLE 29-25: ADC MODULE SPECIFICATIONS (PARTIAL REPRESENTATION)

## 15. Module: Electrical Specifications (DC Specification)

Table 29-5 ("BOR Trip Points") has changed to reflect the functionality of the LPBOR trip point (BORV<1:0> = 00), and to make other typographic corrections. The minimum and maximum values for the BOR trip points in Table 29-5 have changed. The new version of the table is shown below (changes in **bold**).

## TABLE 29-5: BOR TRIP POINTS

Standar Operati	Standard Operating Conditions (unless otherwise stated) Operating temperature $-40^{\circ}C \le TA \le +85^{\circ}C$ for industrial								
Param No.	Sym	Characteristic		Min	Тур	Max	Units	Conditions	
DC19		BOR Voltage on	BOR <b>V =</b> 00		_	_	_	Note (1)	
	VDD Transition		BORV = 01	2.92	3	3.25	V		
			BORV = 10	2.63	2.7	2.92	V		
			BORV = 11	1.75	1.82	2.01	V		

Note 1: LPBOR re-arms the POR circuit, but does not cause a BOR.

## APPENDIX A: DOCUMENT REVISION HISTORY

### Rev A Document (6/2009)

Initial release of this document; issued for revision A5. Includes silicon issues 1 (CTMU), 2 (Resets – BOR), 3 (Core – ICSP), 4 (Core – Deep Sleep), 5 (Memory – Code Protection), 6 (Comparator) and 7 (SPI – Enhanced Buffer Mode). Includes data sheet clarifications 1 (Memory), 2 (Electrical Specifications – AC Specifications), 3-6 (Electrical Specifications – DC Specifications), 7 (A/D) and 8 (Comparators).

### Rev B Document (6/2009)

Revision issued for silicon revision A6. Existing silicon issues 1 (CTMU), 2 (Resets – BOR), 4 (Core – Deep Sleep), 6 (Comparator) and 7 (SPI – Enhanced Buffer Mode) added to revision A6. No new issues added.

### Rev C Document (10/2009)

Revision issued for silicon revision A7. Existing silicon issues 1 (CTMU), 2 (Resets – BOR), 4 (Core – Deep Sleep), 6 (Comparator) and 7 (SPI – Enhanced Buffer Mode) added to revision A7. Added new silicon issue 8 (I/O Ports – PORTA and PORTB).

To revision B of the data sheet, adds data sheet clarifications 9 (Pin Diagrams), 10 (A/D Converter – AD1CHS Register), 11 (A/D Converter – AD1CHS Register), 12 (Special Features – Configuration Bits), 13 (Power-Saving Features) and 14 (Electrical Specifications – AC Specifications).

## Rev D Document (10/2009)

Typographic correction: updated Table 2 with the correct associations between silicon issues and silicon revisions.

#### Rev E Document (4/2010)

Added new silicon issue 9 (I/O Ports – PORTA and PORTB) to all silicon revisions.

Updated existing silicon issue 8 to include additional interactions and work arounds between RA0 and RB0.

Added data sheet clarification 15 (Electrical Specifications – DC Specifications) to revision B of the data sheet.

Updated revision history to include entry for revision D.

## Rev F Document (11/2010)

Revision issued for silicon revision B0. Existing silicon issues 2 (Resets – BOR) and 6 (Comparator) added to revision B0.

Amended existing silicon issue 8 (I/O Ports – PORTA and PORTB), to change "digital input" to analog input" at the end of the fourth paragraph.

Added new silicon issue 10 (Core – Low Power BOR) to silicon revisions A5, A6 and A7.

Added new silicon issues 11, 12 (Comparator) and 13 (Core – Doze Mode) to silicon revisions A5, A6 and A7.

Removed data sheet clarification 16 (Electrical Specifications – DC Specifications) to revision B of the data sheet.

Removed data sheet clarification 6 (Electrical Specifications – DC Specifications) and combined it with data sheet clarification 16 which is now data sheet clarification 15.

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